## Search Notes Application/Control No. Applicant(s)/Patent Under Reexamination DIPIANO ET AL. Examiner Kim, Jennifer Art Unit 1617

| SEARCHED |          |            |          |  |  |
|----------|----------|------------|----------|--|--|
| Class    | Subclass | Date       | Examiner |  |  |
| 514      | 899      | 3/30/2007  | jmk      |  |  |
| 424      | 430      | 3/30/2007  | jmk      |  |  |
|          | updated  | 10/28/2007 | jmk      |  |  |
|          | Updated  | 7/16/2008  | jmk      |  |  |

| SEARCH NOTES               |            |          |  |  |  |
|----------------------------|------------|----------|--|--|--|
| Search Notes               | Date       | Examiner |  |  |  |
| inventor search; STN, WEST | 3/30/2007  | jmk      |  |  |  |
| updated;STIC               | 10/28/2007 | jmk      |  |  |  |
| Updated                    | 7/16/2008  | jmk      |  |  |  |

| INTERFERENCE SEARCH |          |      |          |  |  |
|---------------------|----------|------|----------|--|--|
| Class               | Subclass | Date | Examiner |  |  |
|                     |          |      |          |  |  |

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